Directly Probing Local Coordination, Charge State and Stability of Single Atom Catalysts

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Single atom (SA) catalysis is arguably becoming the most active new frontier in catalysis science. Aided by recent advances in practical synthetic methodologies, characterization techniques and computational modeling, a large number of single atom catalysts (SACs) have been found to exhibit exceptional performance for a wide variety of chemical reactions. Visualizing dynamic structure evolution of SACs anchored by various supports in real space offers direct experimental evidence for the understanding of their structure-property relationships. Site-specific information at atomic spatial resolution, obtained by in situ (S)TEM is an essential addition to other in situ techniques (e.g., X-ray photoelectron spectroscopy, X-ray absorption fine structure spectroscopy, et al.), which offer averaged information over larger length scales. In this talk, we present our TEM studies of various catalyst systems to highlight the advantages of TEM on catalysis research: (1) the dynamic evolution of pre-treatment of Pt/TiO₂ SAC captured by in situ atmospheric aberration-corrected scanning transmission electron microscopy (AC-STEM); (2) determination of charge state of Pt SAs by advanced electron energy-loss spectroscopy (EELS); (3) experimental and theoretical understanding of the local coordination of single atom catalysts on two-dimensional (2D) material supports.

We employed in situ AC-STEM at atmospheric pressure to examine the mobility of Pt atoms on the TiO₂ support. As shown in Fig.1, the Pt atom remained at the same location on the TiO₂ support during the exposure to mild oxidation (300 °C, 760 Torr of O₂) and mild reduction (250 °C, 760 Torr of 5% H₂) conditions, respectively. However, following 30 min of harsh reduction (exposure to 760 Torr of 5% H₂ at 450 °C), the Pt atom moved about 1.6 nm, reflecting the evolution of its anchoring site and local coordination, and greatly improves the activity of CO oxidation of the Pt/TiO₂ SAC, which is further demonstrated by the ex situ activity test [1].

In addition, the stability of the supported single metal atom is strongly dependent on its charge states, which is also crucial to elucidate the reaction mechanism. EEL spectra of Pt N edges were used to interrogate the charge state of the Ptiso species on various oxide supports. On the basis of a comparison to reference spectra, the charge state of Pt SA can be experimentally distinguished. For Ptiso/CeO₂ catalysts, it was concluded that the oxidation state of this Ptiso species absorbed on (111) surface facets of CeO₂ is +4. This agrees with the expected charge state of the Ptiso species following oxidation that has been predicted and observed in model system studies, and the XAS measurements [2].

Furthermore, integrating SAs with structurally well-defined 2D 1T-MoS₂ support enables quantitative identification of SA’s anchoring sites, coordination environments, and bonding information [3]. Combining low-voltage AC-STEM imaging and first-principles calculations, the local coordination and anchoring structure of single atom are unambiguously identified in several catalysts. Fig. 2(a) displays the atomic resolution STEM image of Zn/1T-MoS₂ sample at 60 kV. Atomic column #3 of the experimental...
line profile of ADF intensity in Fig. 2(b) is obviously brighter than surrounding atom columns, indicating the existence of the SA in that position. Compared to simulated images of two different structures in Figs. 2(c) and 2(d), the observed SA was assigned to the absorbed Zn model, which was predicted by first-principles calculations. The experimental intensity ratio between #3 and an average of surrounding Mo positions is 1.95, which is consistent with the simulation value (2.05) of the absorbed model [4].

Figure 1. In situ AC-STEM characterization of Ptiso/TiO2. (a–c) In situ AC-STEM images of Ptiso/TiO2 after 30 min at different annealing conditions: 300 °C, 760 torr of O2 for 30 min (a); 250 °C, 760 torr of 5% H2 (balanced with Ar) for 30 min (b); 450 °C, 760 torr of 5% H2 (balanced with Ar) for 30 min (c). The yellow circles identify the same Pt single atom. A false-coloring scale was used in (a–c) to enhance contrast on the Pt atom. (d) Intensity profile of a line scan (along the yellow arrows) shown in (a) and (c) normalized to the identified Pt atom.

Figure 2. Quantitative identification of bonding structure of Zn SA on 1T-MoS2 support. (a) Atomic resolution annular dark-field (ADF) STEM image of Zn/1T-MoS2 at 60 kV. The red arrows point to the locations of Zn SAs. (b) Comparison of intensity profiles from the experimental image and two simulated images of replaced and absorbed models respectively. (c) Side view of the atomic structure of replaced Zn model and associated simulated STEM image. The yellow, green and red balls are S, Mo and Zn atoms respectively. (d) Side view of the atomic structure of absorbed Zn model and associated simulated STEM image. Scale bars in (a, c, d) are all 0.5 nm.

References